

<b>Notice of References Cited</b>	Application/Control No. 10/595,627		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Thuy N. Pardo		Art Unit 2627	Page 1 of 1

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*	B	US-2001/0036136	11-2001	Fukushima et al.	369/53.18
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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